

Search Notes**Application/Control No.**

10/770,119

Examiner

Toan M. Le

Applicant(s)/Patent under Reexamination

KADABA, NAGESH

Art Unit

2863

SEARCHED

Class	Subclass	Date	Examiner
702	184	5/19/2005	TL
340	572.1	5/19/2005	TL
340	539	5/19/2005	TL
340	988	5/19/2005	TL
705	28	5/19/2005	TL
Above	Updates	10/14/2005	TL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
RFID Environment Track Scan Sensor	5/19/2005	TL
Environment Sensor, Scan, Tag, Transport	5/19/2005	TL
Environment Sensor, Scan, Track, Monitor, Transport	5/19/2005	TL
East- See Search History Printout	10/14/2005	TL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner